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292006US0PCT Docket No.

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

IN RE APPLICATION OF:

Takuhiro USHINO, et al.

SERIAL NO:

New U.S. PCT Application Based on PCT/JP04/17800

GAU:

FILED:

Herewith

EXAMINER:

FOR:

WAVELENGTH PLATE

INFORMATION DISCLOSURE STATEMENT UNDER 37 CFR 1.97

COMMISSIONER FOR PATENTS ALEXANDRIA, VIRGINIA 22313

Applicant(s) wish to disclose the following information.

REFERENCES

Lr.	NENCES 1 Court Propert and listed on the
	The applicant(s) wish to make of record the references cited in the International Search Report and listed on the attached form PTO-1449. Copies of the listed references are attached, where required, as are either statements of relevancy or any readily available English translations of pertinent portions of any non-English language
	references.
	CICIENCES.

☐ A check or credit card payment form is attached in the amount required under 37 CFR §1.17(p).

RELATED CASES

ATED CASES
Attached is a list of applicant's pending application(s), published application(s) or issued patent(s) which may be related to the present application. In accordance with the waiver of 37 CFR 1.98 dated September 21, 2004, copies of the cited pending applications are not provided. Cited published and/or issued patents, if any, are listed on the attached PTO form 1449.
attached 1 to folia 1 (2)

☐ A check or credit card payment form is attached in the amount required under 37 CFR §1.17(p).

CERTIFICATION

☐ Each item of information contained in this information disclosure statement was first cited in any communication from a foreign patent office in a counterpart foreign application not more than three months prior to the filing of this statement.

□ No item of information contained in this information disclosure statement was cited in a communication from a foreign patent office in a counterpart foreign application or, to the knowledge of the undersigned, having made reasonable inquiry, was known to any individual designated in 37 CFR §1.56(c) more than three months prior to the filing of this statement.

DEPOSIT ACCOUNT

Please charge any additional fees for the papers being filed herewith and for which no check or credit card payment is enclosed herewith, or credit any overpayment to deposit account number 15-0030. A duplicate copy of this sheet is enclosed.

Respectfully submitted,

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SHEET 1 OF 1

Form PTO 1449 (Modified)	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE			ATTY DOCKET NO. 292006US0PCT		New U.S. PCP Application			
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LIST OF REFERENCES CITED BY APPLICANT			APPLICANT Tokyybira LISHINO ot ol						
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				U.S. PATENT DOCUMENTS		<u> </u>			
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	DOCUMENT DATE		COUNTRY		TRANSLATION YES NO				
	AO	2001-101700	04/13/01	JP (English abstract only, equivalent of US6580674, US2003/0174631 & US2003/0123371)			NO		
	AP	2001-311821	11/09/01	JP (English abstract only)			NO		
	AQ	2002-341290	11/27/02	JP (English abstract only)			NO		
	AR	2001-159744	06/12/01	JP (English abstract only)			NO		
	AS	2001-272542	10/05/01	JP (English abstract only)			NO		
	AT	2003-270435	09/25/03	JP (English abstract only, equivalent of US2003/0151705 & US6747720)			NO		
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		OTHER R	EFERENCES (Including Author, Title, Date, Pertinent	Pages, e	tc.)			
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Examiner	Examiner Date Considered								
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